

GaAs HEMT LOW NOISE AMPLIFIER, 57 - 65 GHz

Typical Applications

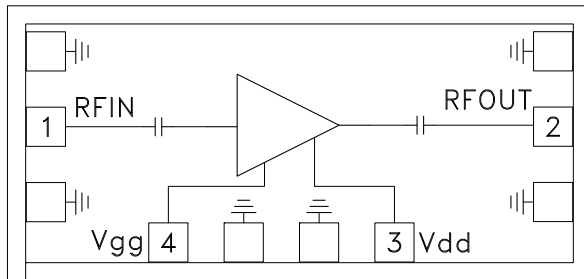
This HMC-ALH382 is ideal for:

- Short Haul / High Capacity Links
- Wireless LANs
- Military & Space

Features

- Noise Figure: 3.8 dB
- P1dB: +12 dBm
- Gain: 21 dB
- Supply Voltage: +2.5V
- 50 Ohm Matched Input/Output
- Die Size: 1.55 x 0.73 x 0.1 mm

Functional Diagram



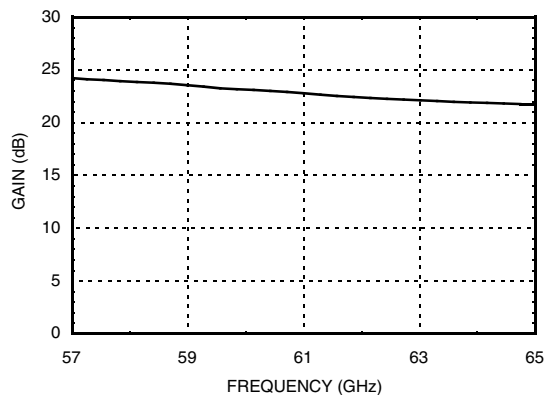
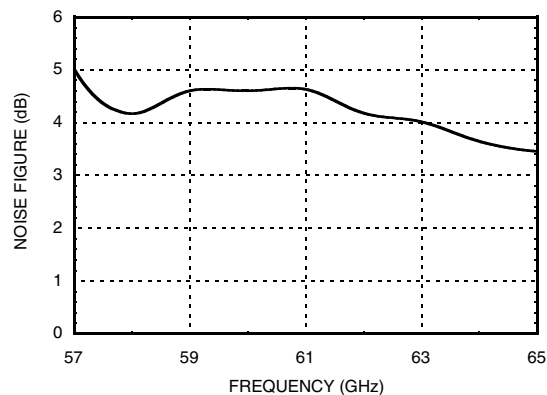
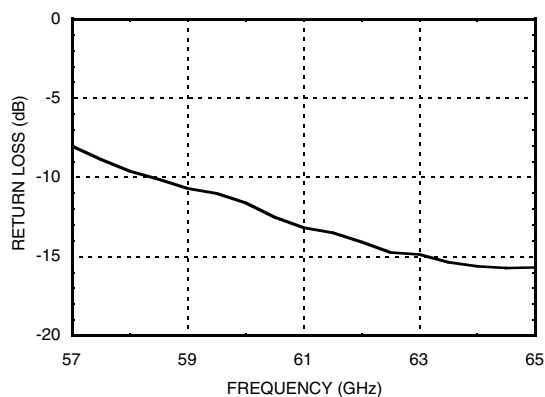
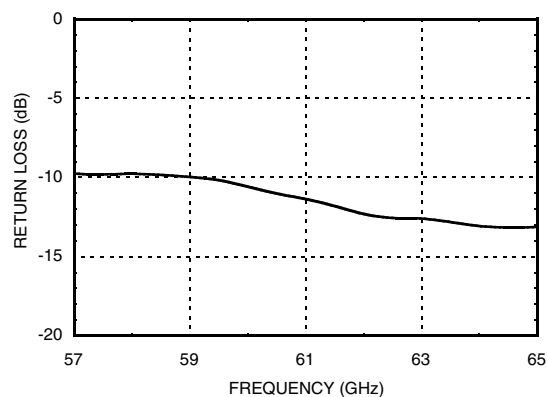
General Description

The HMC-ALH382 is a high dynamic range, four stage GaAs HEMT MMIC Low Noise Amplifier (LNA) which operates between 57 and 65 GHz. The HMC-ALH382 features 21 dB of small signal gain, 4 dB of noise figure and an output power of +12 dBm at 1dB compression from a +2.5V supply voltage. All bond pads and the die backside are Ti/Au metallized and the amplifier device is fully passivated for reliable operation. This versatile LNA is compatible with conventional die attach methods, as well as thermocompression and thermosonic wirebonding, making it ideal for MCM and hybrid microcircuit applications. All data shown herein is measured with the chip in a 50 Ohm environment and contacted with RF probes.

Electrical Specifications, $T_A = +25^\circ C$, $V_{dd} = 2.5V$, $I_{dd} = 64 mA^*$

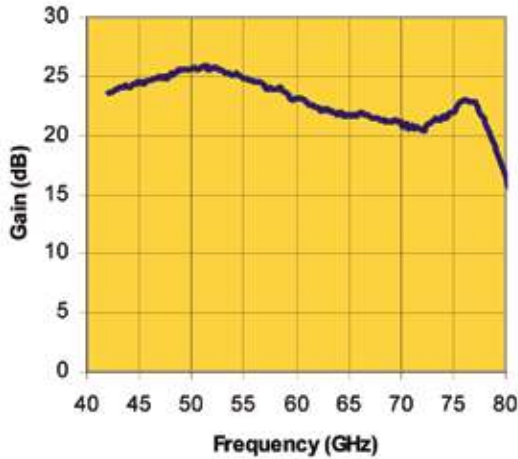
| Parameter | Min. | Typ. | Max. | Units |
|--|------|---------|------|-------|
| Frequency Range | | 57 - 65 | | GHz |
| Gain | 19 | 21 | | dB |
| Noise Figure | | 4 | 5.5 | dB |
| Input Return Loss | | 12 | | dB |
| Output Return Loss | | 10 | | dB |
| Output Power for 1 dB Compression (P1dB) | | 12 | | dBm |
| Supply Current (I_{dd})($V_{dd} = 2.5V, V_{gg} = -0.3V$ Typ.) | | 64 | 100 | mA |

*Unless otherwise indicated, all measurements are from probed die
 [2] Adjust Vgg between -1V to +0.3V (Typ. -0.2V) to achieve $I_{dd, total} = 64 mA$

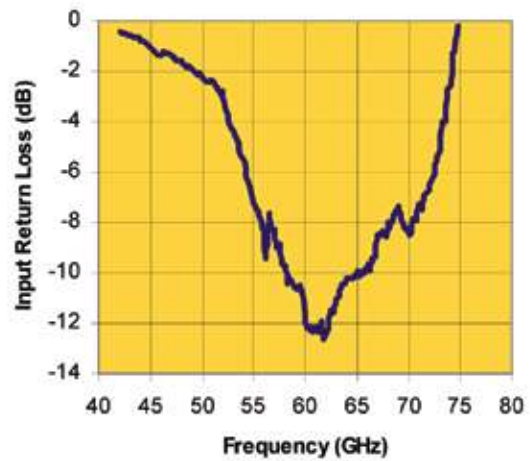
Linear Gain vs. Frequency

Noise Figure vs. Frequency

Input Return Loss vs. Frequency

Output Return Loss vs. Frequency


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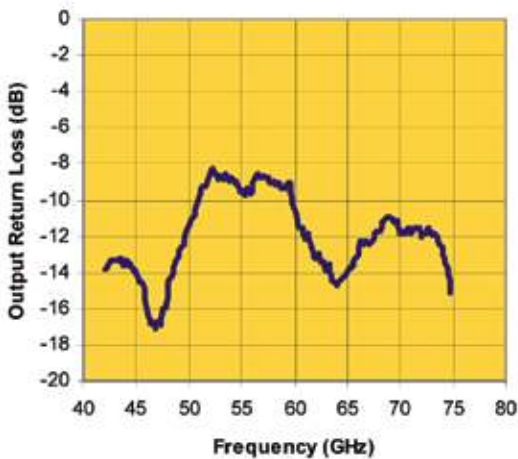
Wideband Linear Gain



Wideband Input Return Loss



Wideband Output Return Loss



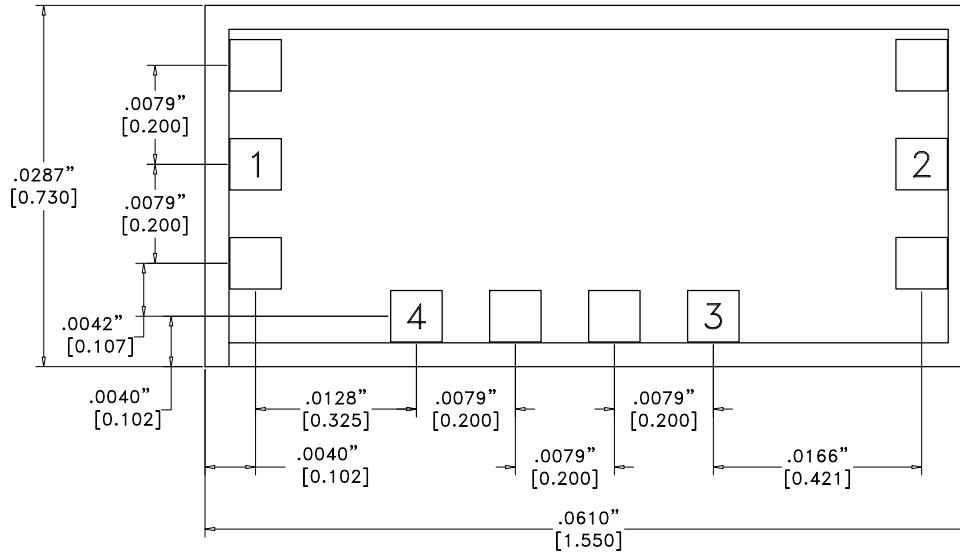
Absolute Maximum Ratings

| | |
|---|----------------|
| Drain Bias Voltage | +5.5 Vdc |
| Gate Bias Voltage | -1 to +0.3 Vdc |
| Channel Temperature | 180 °C |
| Thermal Resistance (channel to die bottom) | 108.4 °C/W |
| Continuous Pdiss (T= 85 °C) (derate 9.2 mW/°C above 85 °C) | 0.87W |
| RF Input Power | -5 dBm |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature | -55 to +85 °C |



**ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS**

Outline Drawing



Die Packaging Information ^[1]

| Standard | Alternate |
|-----------------|-----------|
| GP-5 (Gel Pack) | [2] |

[1] Refer to the "Packaging Information" section for die packaging dimensions.

[2] For alternate packaging information contact Hittite Microwave Corporation.

NOTES:

1. ALL DIMENSIONS ARE IN INCHES [MM].
2. TYPICAL BOND PAD IS .004" SQUARE.
3. BACKSIDE METALLIZATION: GOLD.
4. BACKSIDE METAL IS GROUND.
5. BOND PAD METALLIZATION: GOLD.
6. CONNECTION NOT REQUIRED FOR UNLABELED BOND PADS.
7. OVERALL DIE SIZE $\pm .002$ "

Pad Descriptions

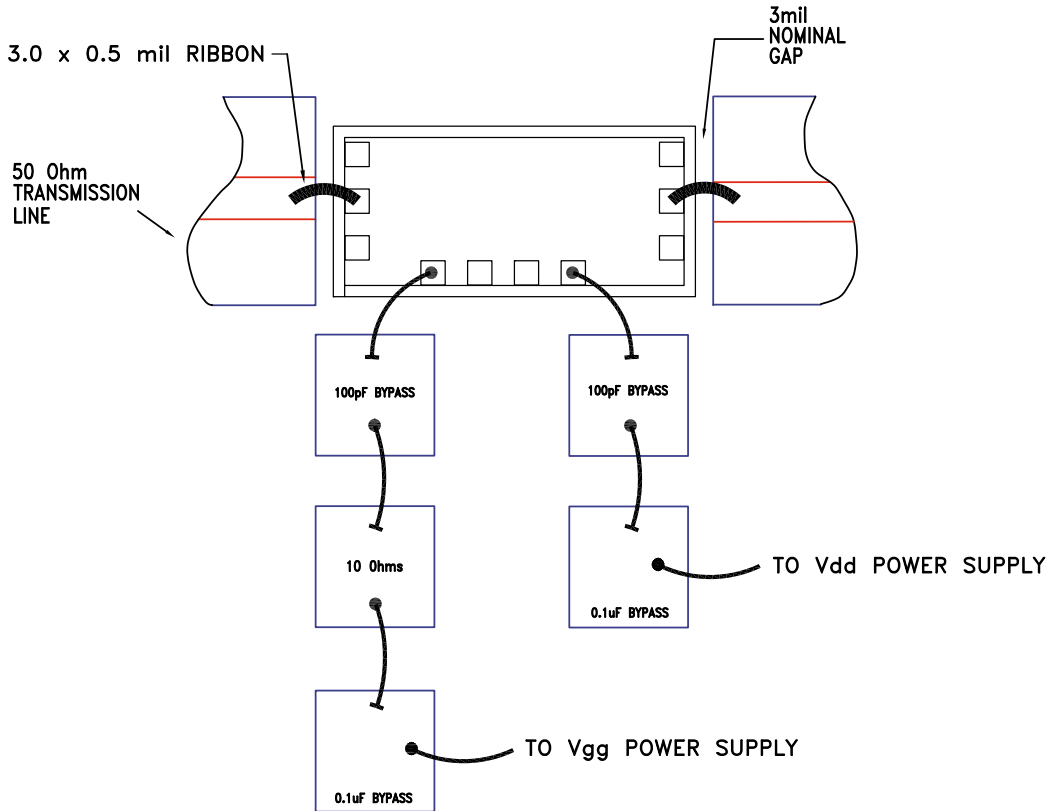
| Pad Number | Function | Description | Interface Schematic |
|------------|----------|---|---------------------|
| 1 | RFIN | This pad is AC coupled and matched to 50 Ohms. | |
| 2 | RFOUT | This pad is AC coupled and matched to 50 Ohms. | |
| 3 | Vdd | Power Supply Voltage for the amplifier. See assembly for required external components. | |
| 4 | Vgg | Gate control for amplifier. Please follow "MMIC Amplifier Biasing Procedure" application note. See assembly for required external components. | |
| Die bottom | GND | Die bottom must be connected to RF/DC ground. | |

**GaAs HEMT LOW NOISE
AMPLIFIER, 57 - 65 GHz**

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AMPLIFIERS - LOW NOISE - CHIP

Assembly Diagram



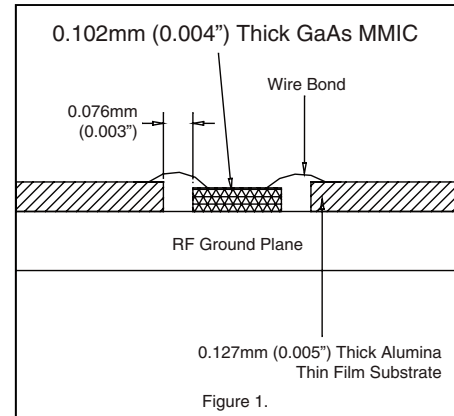
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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be placed as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm to 0.152 mm (3 to 6 mils).



Handling Precautions

Follow these precautions to avoid permanent damage.

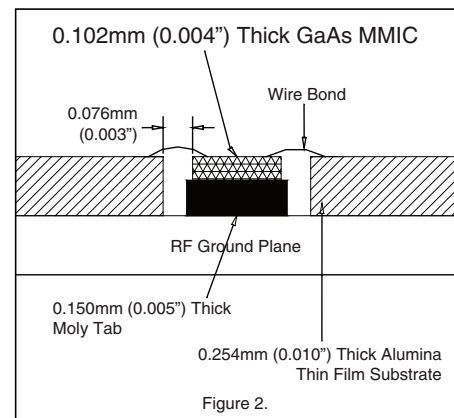
Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.



Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

RF bonds made with 0.003" x 0.0005" ribbon are recommended. These bonds should be thermosonically bonded with a force of 40-60 grams. DC bonds of 0.001" (0.025 mm) diameter, thermosonically bonded, are recommended. Ball bonds should be made with a force of 40-50 grams and wedge bonds at 18-22 grams. All bonds should be made with a nominal stage temperature of 150 °C. A minimum amount of ultrasonic energy should be applied to achieve reliable bonds. All bonds should be as short as possible, less than 12 mils (0.31 mm).